# ECEN721: Optical Interconnects Circuits and Systems Spring 2024

#### Lecture 9: Mach-Zehnder Modulator Transmitters



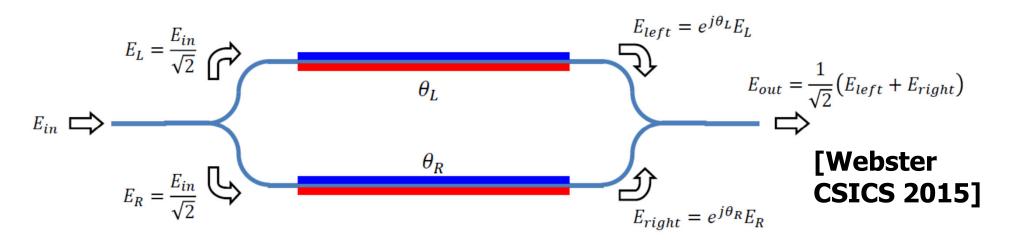
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#### Announcements

Homework 3 is due today

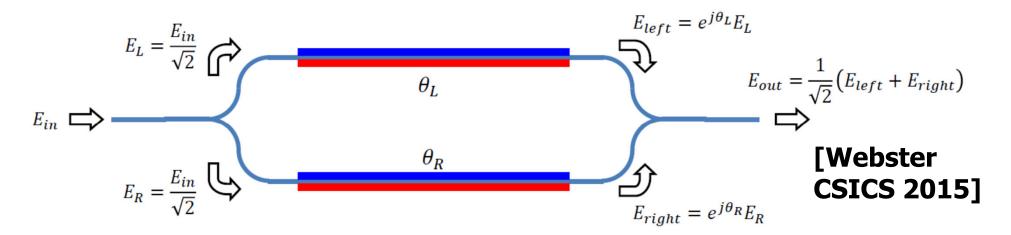
- Reading
  - Sackinger Chapter 8

# Mach-Zehnder Modulator (MZM)



- An optical interferometer is formed with the incoming light split, experiencing phase shifts through the two paths, and then recombined
- If the phase shift between the two waves is 0°, then there is maximum constructive interference and the output intensity is highest (ideal logic 1)
- If the phase shift between the two waves is 180°, then there is maximum destructive interference and the output intensity is lowest (ideal logic 0)
- An MZM changes the relative phase between the two paths with a modulation voltage via the electrooptic effect, producing the modulated output signal

# Ideal MZM Response



Assuming no loss and a perfect 50/50 splitter/combiner

$$\Delta \phi = \frac{(\theta_R - \theta_L)}{2} \qquad \phi = \frac{(\theta_R + \theta_L)}{2}$$

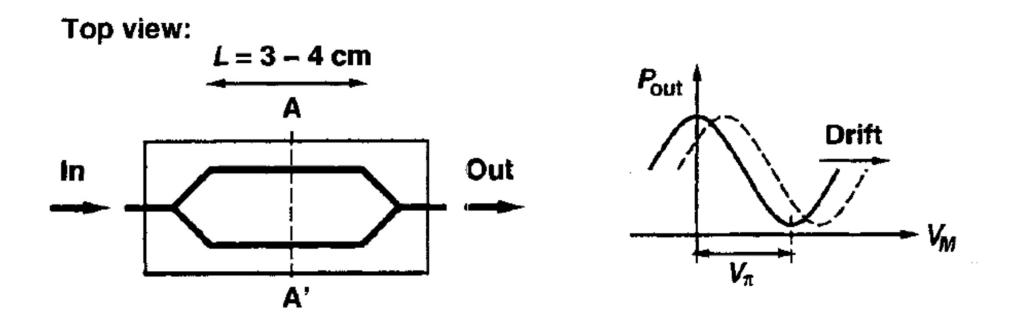
Field Response

**Intensity Response** 

$$E_{out} = E_{in} \cos(\Delta \phi) e^{j\phi}$$
  $P_{out} = |E_{out}|^2 = \frac{1}{2} |E_{in}|^2 [1 + \cos(\theta_R - \theta_L)]$ 

$$\frac{P_{out}}{P_{in}} = \frac{1}{2} \left[ 1 + \cos(\theta_R - \theta_L) \right]$$

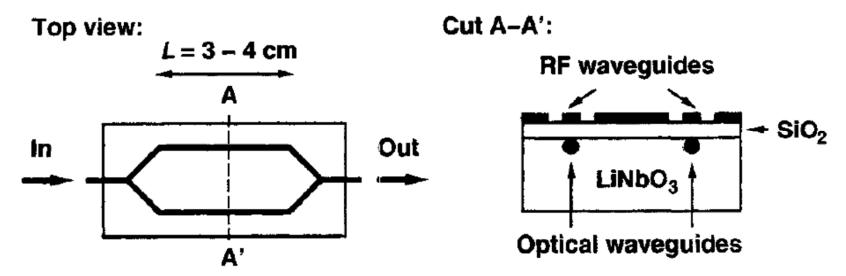
# Ideal MZM Response



$$\frac{P_{out}}{P_{in}} = \frac{1}{2} \left[ 1 + \cos(\theta_R - \theta_L) \right] = \frac{1}{2} \left[ 1 + \cos\left(\pi \cdot \frac{V_M}{V\pi}\right) \right]$$

Here  $V_M$  is the differential voltage applied between the two input ports and  $V_{\pi}$  is the voltage necessary for  $\pi$  phase shift, also called the switching voltage.

# Single or Dual-Drive



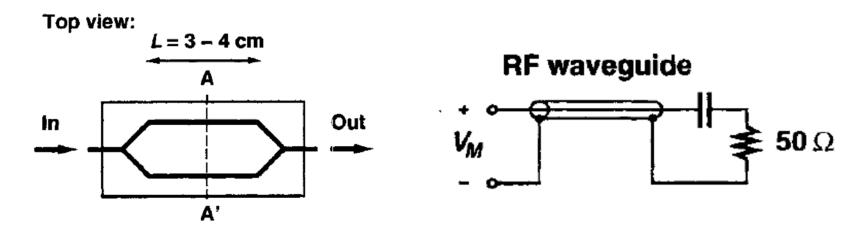
#### Single-Drive MZM

- Only one are is driven in a single-ended manner
- While only requiring a single high-speed input signal, there is generally some chirp in the output signal
- Need to apply the full  $V_{\Pi}$  to one are to get maximum extinction ratio

#### Dual-Drive MZM

- Both arms are driven in a differential/push-pull manner
- This ideally results in no chirp at the output
- Only need to apply  $\pm V_{\Pi}/2$  on the two arms to get maximum extinction ratio

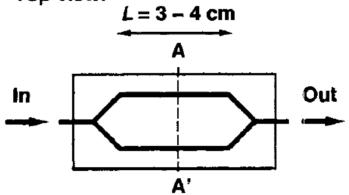
# $V_{\Pi}^*L$ Product



- The amount of phase shift generated by an MZM is proportional to voltage applied and the length of the phase shifter
- Thus, an MZM figure of merit is the  $V_{\Pi}^*L$  product
- Typical values
  - Lithium Niobate: 14Vcm
  - Silicon (Depletion-Mode): 4Vcm
  - Silicon (MOS Capacitor): 0.2Vcm
- These large VP\*L products lead to long controlled-impedance electrodes which must be terminated
- A key challenge is matching the propagation speed of the electrical modulation signal with the optical beam

# Chirp Parameter





$$\alpha = \frac{v_{M1}^{pp} + v_{M2}^{pp}}{v_{M1}^{pp} - v_{M2}^{pp}}$$

where  $v_{M1}^{pp}$  and  $v_{M2}^{pp}$  are the voltage swings on the two modulator arms.

With differential signaling  $v_{M1}^{pp} = -v_{M2}^{pp}$  and the chirp is ideally zero.

If  $v_{M1}^{pp} < -v_{M2}^{pp}$  then we can actually have negative chirp and potential pulse compression when passed through a fiber with positive D

If  $v_{M1}^{pp} = v_{M2}^{pp}$ , then we get a purely phase modulated signal and the MZM can be used for phase modulation (QPSK), rather than amplitude modulation.

#### Silicon Free Carrier Plasma Dispersion Effect

- The refractive index of silicon can be changed through the free-carrier plasma dispersion effect where the electron and hole densities change the refractive index
- Unfortunately, this also changes the waveguide's absorption (loss)
- This effect is utilized for all present high-speed silicon photonic modulators

$$\Delta n = \Delta n_e + \Delta n_h = -8.8 \times 10^{-22} (\Delta N_e) - 8.5 \times 10^{-18} (\Delta N_h)^{0.8}$$

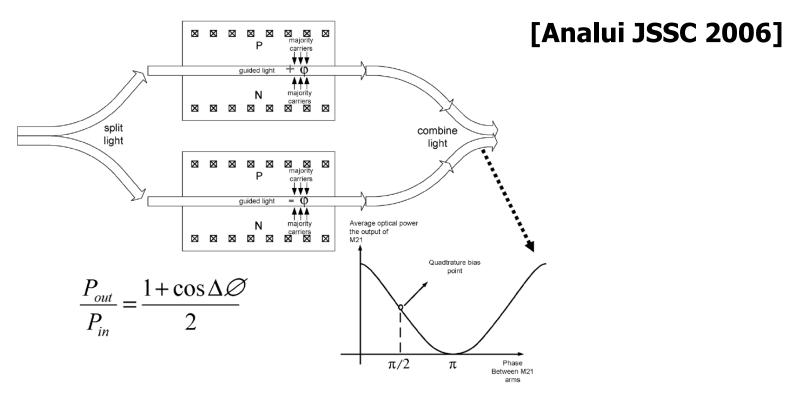
$$\Delta \alpha = \Delta \alpha_e + \Delta \alpha_h = 8.5 \times 10^{-18} (\Delta N_e) + 6.0 \times 10^{-18} (\Delta N_h)$$

$$\Delta n = \Delta n_e + \Delta n_h = -6.2 \times 10^{-22} (\Delta N_e) - 6.0 \times 10^{-18} (\Delta N_h)^{0.8}$$

$$\Delta \alpha = \Delta \alpha_e + \Delta \alpha_h = 6.0 \times 10^{-18} (\Delta N_e) + 4.0 \times 10^{-18} (\Delta N_h)$$

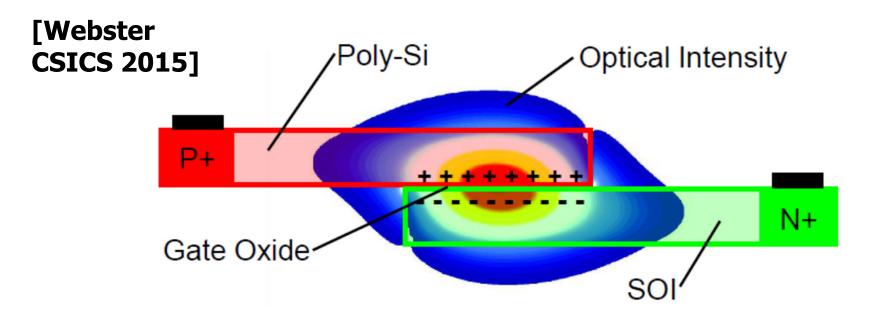
$$\lambda = 1310 \text{nm}$$

# Silicon Depletion-Mode MZM



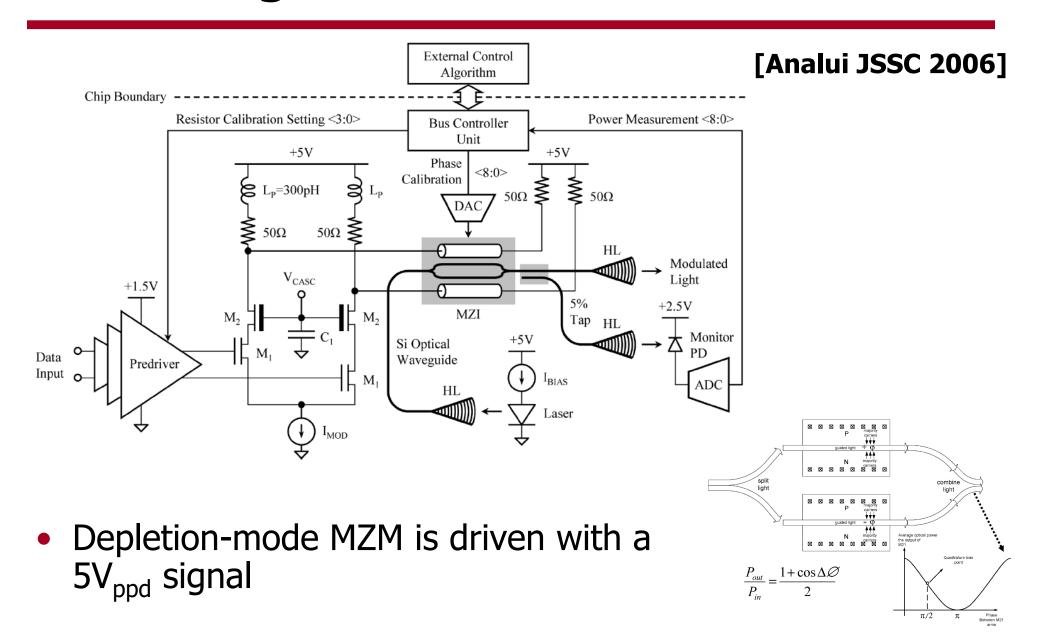
- Here the silicon waveguide is doped as a PN junction
- The depletion region is modulated as a function of the applied reverse bias voltage
- The resultant change in the carrier density within the depletion region causes the refractive index to change

## MOS Capacitor Accumulation Mode MZM



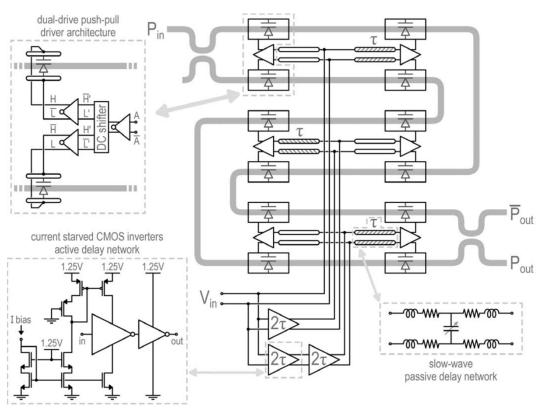
- With a MOS capacitor structure, a change in the accumulation carrier density occurs with the applied gate voltage
- The resultant change in the carrier density within the MOS capacitor region causes the refractive index to change
- Very large changes in charge density can be achieved!

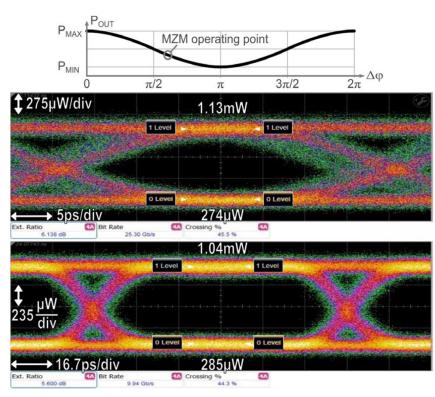
# Traveling-Wave MZM Driver



### Distributed MZM Driver

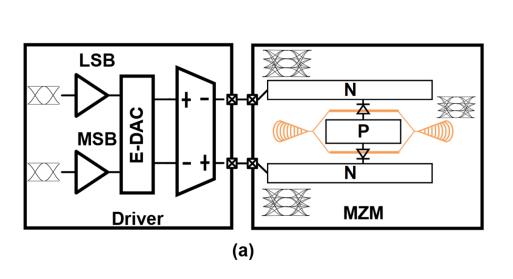
#### [Cignoli ISSCC 2015]

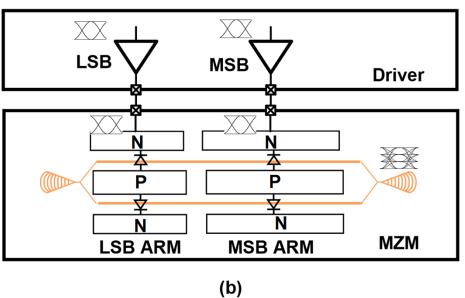




- Allows for CMOS style drivers
- Well suited for a monolithic silicon photonic process
- Hybrid integration requires may pad connections between CMOS/silicon photonic die

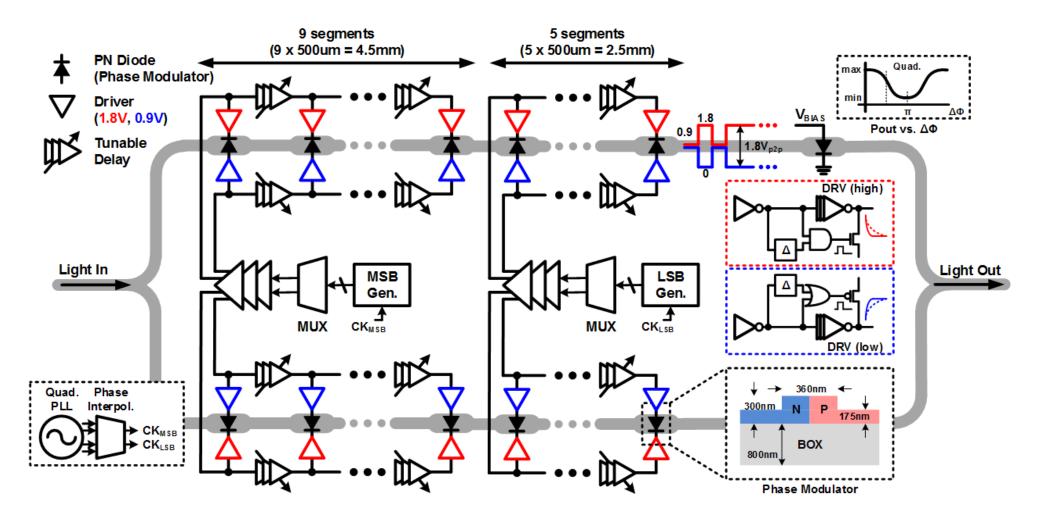
## PAM4 Level Generation w/ MZMs





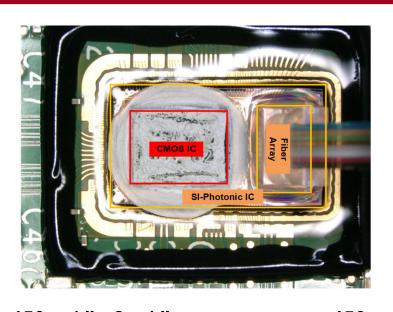
- E-DAC PAM4 TX
  - PAM4 driver bandwidth and swing limitation
  - Multi current/voltage level
- O-DAC PAM4 TX
  - Velocity mismatch between LSB and MSB
  - Multi driver design

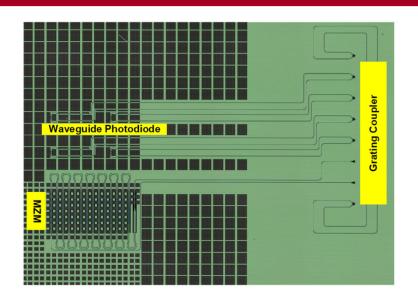
## Optical DAC NRZ/PAM4 Reconfigurable MZM TX

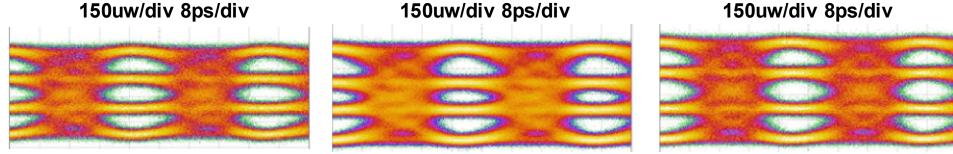


5 LSB segments and 9 MSB segments

### 56Gb/s PAM4 16nm FinFET CMOS Prototype







	Segment setting	ER	RLM	EYE width	Eye height
(a)	3 LSB+6 MSB	6.35dB	0.942	5.12ps	11.6uW
(b)	4 LSB+7 MSB	8.14dB	0.896	5.01ps	4.6uW
(c)	4 LSB+8 MSB	8.46dB	0.944	5.7ps	18.4uW

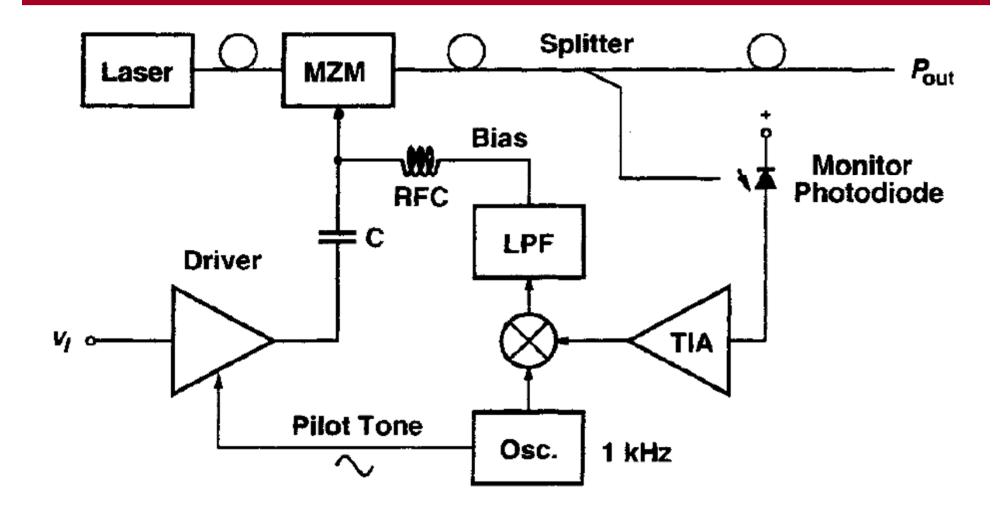
## MZM Transmitter Performance Summary

References	This Work	Cignoli ISSCC 2015	Temporiti ISSCC 2016	<b>Q</b> i OFC 2016	Xiong Optica 2016
Data Rate (Gb/s)	56	25	56	50	56
Modulation	NRZ/PAM4	NRZ	NRZ	NRZ/PAM4	PAM4
Modulator Structure	SE	SE	TW	TW	TW
Integration Technology	Copper Pillar	Copper Pillar	Copper Pillar	Wire Bond	Monolithic
MZM Length(mm)	7	3	3	NA	3
Test Pattern	PRBS 23	PRBS 7	PRBS 31	PRBS 31	PRBS 23
Extinction Ratio (dB)	9.5	4-6	2.5	5.6	6
Power (mW)	708*	275	300	613	135**
Power Efficiency (pJ/bit)	12.6	11	5.35	12.26	2.7
Technology	16nm FinFET	65-nm CMOS	55-nm BiCMOS	65-nm CMOS	90-nm CMOS SOI

<sup>\*</sup> Clocking and data serialization and digital backends power are included

<sup>\*\*</sup> Power Consumption at 50Gbps

### **Automatic Bias Control**



#### Next Time

Electroabsorption Modulator (EAM) TX